

DECLARATION

I, Satsuki Yaegashi of c/o SHIGA INTERNATIONAL PATENT OFFICE, GranTokyo South Tower 1-9-2, Marunouchi, Chiyoda-ku, Tokyo 100-6620 JAPAN, do solemnly and sincerely declare that I am conversant with the Japanese and English Languages and that I believe:

that the expression "particles having an average particle size of 10 μm or less" at paragraphs [0004], [0020], [0030], [0031][Table1], and Abstract of the English specification (11 occurrences) should be amended to "particles having a particle size of 10 μm or less".

These amendments are merely corrections of inadvertent errors which occurred at the time of the translation into English of the original PCT specification. The attached copy of revised paragraphs [0004], [0020], [0030], [0031][Table1], and Abstract of the English specification is true and correct translation of the corresponding paragraphs of the international patent application No. PCT/JP2005/002210. The English descriptions "particles having an particle size of 10 μm or less" in the English specification at paragraphs [0004], [0020], [0030], [0031][Table1], and Abstract are correct English translations of the Japanese description "10 μm 以下の粒子" in the original Japanese PCT specification at paragraphs [0004], [0020], [0030], [0031][Table1], and Abstract.

I declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issuing thereon.

January 17, 2011

(Date)

S. Yaegashi

Satsuki YAEGASHI